

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/553,675	TAKEI ET AL.	
Examiner	Art Unit	
Duy-Vu N. Deo	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East: key words	4/25/2007	DVD		
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